Application/Control No. O9/538,767 Applicant(s)/Patent Under Reexamination NG, YVONNE Examiner Seung H Lee Applicant(s)/Patent Under Reexamination NG, YVONNE Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6199762-	03-2001	Hohle	235	492
	В	US-5744787-	04-1998	Teicher	235	380
	С	US-5578808-	11-1996	Taylor	235	380
,	D	US-5694471-	12-1997	Chen et al.	380	25
	E	US-6194992-	02-2001	Short et al.	340	5.9
•	F	US-6141752-	10-2000	Dancs et al.	713	172
	G	US-5983273-	11-1999	White et al.	709	229
	Н	US				
	ı	US				
	J	US				
	к	US			t	
	L	US				· · · · · · · · · · · · · · · · · · ·
	м	US				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Cod	Date MM-YYYY	Country	Name	Classification	
	N						
	0	- •					
	Р						
	Q						
	R						
	S						
	Т					·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.